

> RoHS COMPLIANT

N-Channel 30-V (D-S) MOSFET

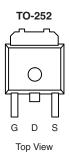
PRODUCT SUMMARY					
V _{DS} (V)	R_{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)		
30	0.0045 at V _{GS} = 10 V	72	33 nC		
	0.0075 at V_{GS} = 4.5 V	56	33110		

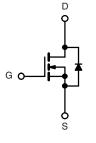
FEATURES

- DT-Trench Power MOSFET
- 100 % Rg and UIS Tested
- PWM Optimized

APPLICATIONS

- LCD Display Backlight Inverters
- DC/DC Converters





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	S T _A = 25 °C, unles	s otherwise not	ed		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	30	v	
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		72 ^a		
Continuous Drain Current (T $= 150$ °C)	T _C = 70 °C		56		
Continuous Drain Current ($T_J = 150 \ ^{\circ}C$)	T _A = 25 °C	I _D	29 ^b		
	T _A = 70 °C		19 ^b	A	
Pulsed Drain Current		I _{DM}	310		
Continuous Source-Drain Diode Current	T _C = 25 °C		72		
Continuous Source-Drain Diode Current	T _A = 25 °C	Is –	4.3 ^b		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	70		
Avalanche Energy		E _{AS}	160	mJ	
	T _C = 25 °C		179		
Maximum Power Dissipation	T _C = 70 °C		114	w	
	T _A = 25 °C	P _D	6.1 ^b	V	
	T _A = 70 °C		3.9 ^b	1	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^b	Steady State	R _{thJA}	18	23	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	1.2	1.8		

Notes:

a. Package limited.

b. Surface mounted on 1" x 1" FR4 board.

SPECIFICATIONS T _J = 25 °C Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	Cynison			.,,,,,	maxi	•	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			44		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 1.0 mA		- 5.9			
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 μA	1.0		3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
0		$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 24 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 70 \text{ °C}$			20		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 V, V_{GS} = 10 V$	72			А	
		$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}$		0.0045	0.0055	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 15 \text{ A}$		0.0075	0.0090		
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 15 \text{ A}$		85		S	
Dynamic ^b				•			
Input Capacitance	C _{iss}			3170			
Output Capacitance	C _{oss}	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		305		pF	
Reverse Transfer Capacitance	C _{rss}			73			
Total Gate Charge		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 20 \text{ A}$		33		nC	
	Qg			18			
Gate-Source Charge	Q _{gs}	V_{DS} = 15 V, V_{GS} = 4.5 V, I_{D} = 15 A		6.6			
Gate-Drain Charge	Q _{gd}			4.1			
Gate Resistance	Rg	f = 1 MHz		2.5		Ω	
Turn-On Delay Time	t _{d(on)}			35			
Rise Time	t _r	V_{DD} = 15 V, R_L = 1 Ω		16		-	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 15$ A, $V_{GEN} = 4.5$ V, $R_g = 1 \ \Omega$		43			
Fall Time	t _f			11			
Turn-On Delay Time	t _{d(on)}			13		- ns - -	
Rise Time	t _r	V_{DD} = 15 V, R_L = 1 Ω		6			
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 20 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		32			
Fall Time	t _f			7			
Drain-Source Body Diode Characteris	tics						
Continuous Source-Drain Diode Current	ا _S	T _C = 25 °C			72	A	
Pulse Diode Forward Current ^a	I _{SM}				310	A	
Body Diode Voltage	V _{SD}	I _S = 10 A		0.7	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			26	37	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 20 A, dl/dt = 100 A/μs, T _{.1} = 25 °C		15	23	nC	
Reverse Recovery Fall Time	t _a	$F = 20 \text{ A}, \text{ u/ul} = 100 \text{ A/}\mu\text{s}, \text{ I}_{\text{J}} = 25 ^{\circ}\text{C}$		11		200	
Reverse Recovery Rise Time	t _b			10		ns	

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



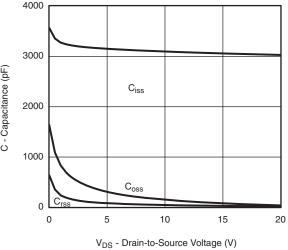
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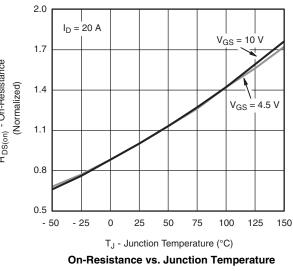
¹⁰⁰ г 1.5 V_{GS} = 10 V thru 5 $V_{GS} = 4 V$ 80 1.2 I_D - Drain Current (A) I_D - Drain Current (A) 60 0.9 40 0.6 T_C = 25 °C 20 V_{GS} = 3 V 0.3 т_с = 125 °С $V_{GS} = 1.5 V$ 0 0.0 2 0.0 0.5 1.0 1.5 2.0 2.5 0 1 V_{DS} - Drain-to-Source Voltage (V) **Output Characteristics** 4000 12 $R_{DS(on)}$ - On-Resistance $(\mathrm{m}\Omega)$ 3000 9 V_{GS} = 4.5 V C - Capacitance (pF) 2000 6 $V_{GS} = 10 V$ 1000 3 Coss 0 0 0 20 40 60 80 100 0 5 I_D - Drain Current (A) **On-Resistance vs. Drain Current** 10 2.0 I_D = 20 A I_D = 20 A V_{GS} - Gate-to-Source Voltage (V) 8 1.7 $V_{DS} = 24 V$ R _{DS(on)} - On-Resistance (Normalized) 6 1.4 4 1.1 2 0.8 0 0.5 0 10 40 20 30 - 25 0 25 - 50 Qg - Total Gate Charge (nC) **Gate Charge**

T_C = - 55 °C 4 3

V_{GS} - Gate-to-Source Voltage (V) **Transfer Characteristics**

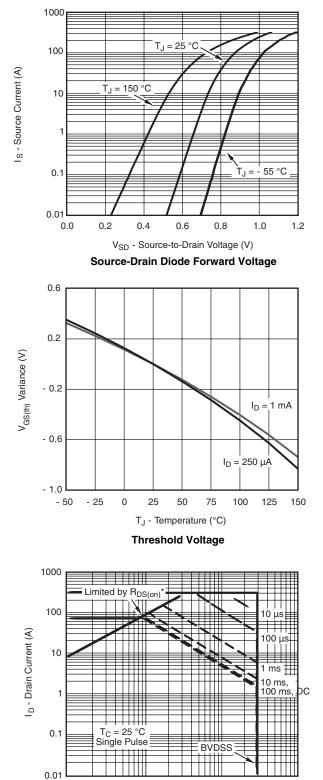


Capacitance

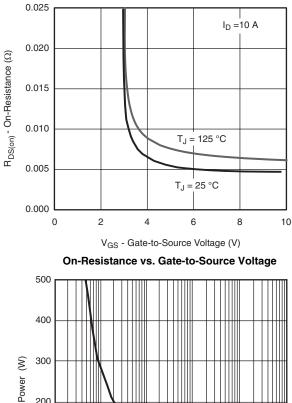


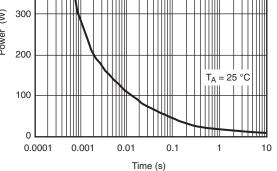


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

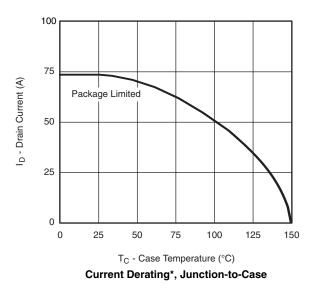


0.1 1 10 100 V_{DS} - Drain-to-Source Voltage (V) * V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified Safe Operating Area, Junction-to-Case



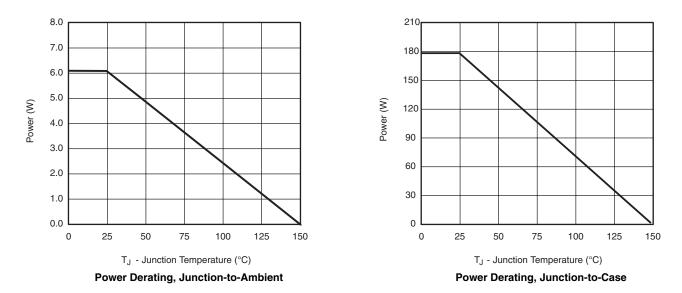


Single Pulse, Junction-to-Ambient





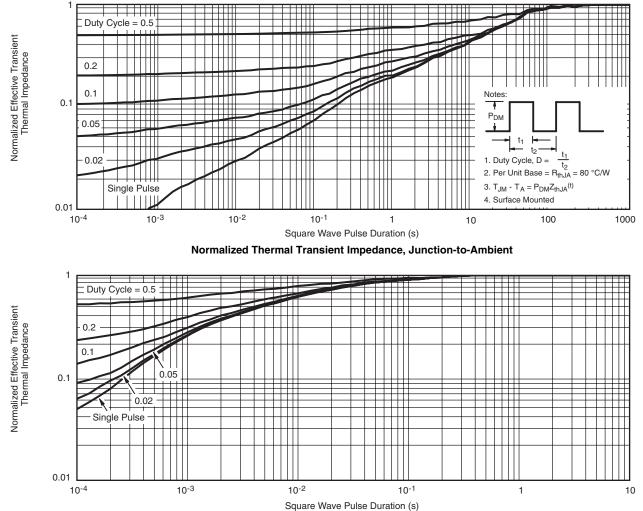
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Case



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